

# Resolution and aberration correction in liquid cell transmission electron microscopy

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# Supplementary information

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### Phase-contrast calculations

To calculate the signal-to-noise ratio (SNR) due to phase contrast in TEM, consider the average scattering potential for the case of a weak-phase object of thickness  $d$ . This calculation was originally published<sup>1</sup> in 2003, and the summary included here was recently published<sup>2</sup>. The contrast is calculated at the interface parallel to the beam direction of a nano-object with the surrounding water via the electron scattering factor  $f(\theta)$  for scattering angle  $\theta$ , which is obtained from the scattering cross section<sup>3</sup>:

$$\frac{d\sigma}{d\Omega} = |f(\theta)|^2 \quad (1)$$

with scattering cross section  $\sigma$  of one atom and the solid angle  $\Omega$ . The cross section of elastic scattering based on the Wentzel potential is given by<sup>3</sup>

$$\frac{d\sigma_{el}}{d\Omega} = 4a_H^2 Z^{2/3} (1 + E/E_0)^2 \frac{1}{1 + (\theta/\theta_0)^2} \quad (2)$$

where  $Z$  is the atomic number,  $E$  is the electron energy,  $a_H$  is the Bohr radius, and the rest energy  $E_0$  is given by

$$E_0 = m_0 c^2 \quad (3)$$

where  $m_0$  is the rest mass of the electron and  $c$  is the speed of light. The characteristic angle is given by<sup>3</sup>

$$\theta_0 = \frac{\lambda Z^{1/3}}{2\pi a_H} \quad (4)$$

with the relativistic wavelength of the electron defined as

$$\lambda = \frac{hc}{\sqrt{2EE_0 + E^2}} \quad (5)$$

where  $h$  is Planck's constant. The phase contrast amplitude is simply obtained from the zero-angle elastic scattering factor<sup>1</sup>  $f(0)$ :

$$f_{el}(0) = 2a_H Z^{1/3} (1 + E/E_0) \quad (6)$$

### Scatter-contrast calculations

The basis of calculations of scatter contrast in TEM or STEM use the partial cross section for elastic scattering  $\sigma_{el}(\theta)$ , which expresses the probability of scattering by an angle  $\theta$  or larger<sup>2,3</sup>

$$\sigma_{el}(\theta) = (1/\pi) Z^{4/3} \lambda^2 (1 + E/E_0)^2 \frac{1}{1 + (\theta/\theta_0)^2} \quad (7)$$

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2. de Jonge, N. Theory of the spatial resolution of (scanning) transmission electron microscopy in liquid water or ice layers. *Ultramicroscopy* **187**, 113-125 (2018).
3. Reimer, L. & Kohl, H. Transmission electron microscopy: Physics of image formation. (Springer, New York, 2008).